What Is Claimed Is:

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- 1. A flame retardant epoxy resin composition comprising (A) a halogen-free epoxy resin with at least 2 epoxy groups within each molecule, (B) a curing agent, and (C) a foaming agent.
- 2. The composition according to claim 1, wherein the epoxy resin of the component (A) comprises a bisphenol A type epoxy resin, a bisphenol F type epoxy resin, a bisphenol S type epoxy resin, a phenol novolak type epoxy resin, a cresol novolak type epoxy resin, a naphthalene type epoxy resin, a biphenyl type epoxy resin, an N-glycidyl compound derived from an aromatic amine and a heterocyclic nitrogen base, or a combination of two or more thereof.
- 3. The composition according to claim 1, wherein the curing agent of the component (B) comprises a C₂ to C₂₀ straight chain aliphatic diamine, a straight chain aliphatic polyvalent amine, an alicyclic amine, an aromatic amine, a dicyanamide, a resol type phenol resin, a novolak type resin, a phenol resin, a polyoxystyrene, an acid anhydride, or a combination of two or more thereof.
- 4. The composition according to claim 1, wherein the curing agent of the component (B) comprises a phenol aralkyl resin having a structure represented by the formula:

$$H$$
 CH_2
 CH_2
 H
 H

5. The composition according to claim 1, wherein the curing agent of the component (B) is a compound with at least two phenolic hydroxyl groups within the molecule.

- 6. The composition according to claim 5, wherein said compound with at least two phenolic hydroxyl groups is a novolak type phenol resin, a resol type phenol resin, a polyoxystyrenes, a phenol aralkyl resin, or a combination of two or more.
- 7. The composition according to claim 1, wherein a decomposition temperature of a foaming agent of said component (C) is at least 180°C.
 - 8. The composition according to claim 1, wherein a decomposition temperature of a foaming agent of said component (C) is at least 200°C.
 - 9. The composition according to claim 1, wherein a decomposition temperature of a foaming agent of said component (C) is at least 250°C.
 - 10. The composition according to claim 1, wherein a quantity of gas generated from a foaming agent of said component (C) is at least 40 ml/g.

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- 11. The composition according to claim 1, wherein a quantity of gas generated from a foaming agent of said component (C) is at least 80 ml/g.
- 20 12. The composition according to claim 1, wherein a quantity of gas generated from a foaming agent of said component (C) is at least 150 ml/g.
 - 13. The composition according to claim 1, wherein said foaming agent of said component (C) comprises azodicarbonamide, azobistetrazole diaminoguanidine, azobistetrazole guanidine, 5-phenyltetrazole, bistetrazole guanidine, bistetrazole piperazine, bistetrazole diammonium, N,N'-dinitrosopentamethylene tetramine, hydrazodicarbonamide, or a combination of two or more thereof.
- 14. The composition according to claim 1, wherein said curing agent of the component (B) is present in a quantity which produces a ratio of the hydroxyl group equivalence of the component (B) relative to the epoxy equivalence of the epoxy resin of the component (A) which falls within a range from approximately 0.5 to 2.0.

- 15. The composition according to claim 1, wherein said curing agent of the component (C) is present in a quantity from 0.01 to 50% by weight based on the whole composition.
- 5 16. The composition according to claim 1, further comprising (D) a filler.
 - 17. A semiconductor encapsulating material comprising a composition according to claim 1.
- 18. A resin encapsulated semiconductor device comprising a semiconductor device and a cured product of the composition according to claim 1 encapsulating said semiconductor device.